Application No.: 10/583,095

## IN THE CLAIMS:

This listing of claims will replace all prior versions and listings of claims in the application

## **Listing of Claims**:

Claims 1-43 (Cancelled)

44. (Currently amended) [[The]] A solid-state imaging apparatus of Claim-43, further emprising being one of pieces diced from an assembly, the solid-state imaging apparatus comprising:

a light-receiving chip having a plurality of light-receiving cells arranged either one dimensionally or two dimensionally on a main surface of a base substrate, the main surface being made up of a light-receiving area on which the light-receiving cells are arranged and a periphery area surrounding the light-receiving area;

a transparent protection plate, at least a part thereof that corresponds to the light-receiving area being transparent; and

a collective lens of the light-receiving [[cell]] cells, wherein

the transparent protection plate has a skirt portion at a periphery thereof,

the skirt portion is positioned on the periphery area of the main surface thereby forming a space between the light-receiving cells and the transparent protection plate,

the assembly is comprised of two layers, the two layers being a sheet of transparent protection plates and a semiconductor wafer of light-receiving chips that are attached to each other such that each transparent protection plate is combined with a corresponding light-receiving chip, and the diced pieces have such diced edges that result by cutting the two layers simultaneously,

the skirt portion is formed of a sealing material, and

the thickness of a space between the transparent protection plate and the light-receiving cells is greater than a height of the collective lens by  $10\mu m-100\mu m$ .

45. (Currently amended) [[The]] A solid-state imaging apparatus of Claim 43, further emprising being one of pieces diced from an assembly, the solid-state imaging apparatus comprising:

a light-receiving chip having a plurality of light-receiving cells arranged either one dimensionally or two dimensionally on a main surface of a base substrate, the main surface being made up of a light-receiving area on which the light-receiving cells are arranged and a periphery area surrounding the light-receiving area;

a transparent protection plate, at least a part thereof that corresponds to the light-receiving area being transparent; and

a collective lens of the light-receiving [[cell]] cells, wherein

the transparent protection plate has a skirt portion at a periphery thereof,

the skirt portion is positioned on the periphery area of the main surface thereby forming a space between the light-receiving cells and the transparent protection plate,

the assembly is comprised of two layers, the two layers being a sheet of transparent protection plates and a semiconductor wafer of light-receiving chips that are attached to each other such that each transparent protection plate is combined with a corresponding light-receiving chip, and the diced pieces have such diced edges that result by cutting the two layers simultaneously,

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the skirt portion is formed of a sealing material, and

a space between the transparent protection plate and the light-receiving cells is filled with a resin whose refractive index is smaller than that of the collective lens.

46. (New) The solid-state imaging apparatus of Claim 44, further comprising a through hole passing through the base substrate.

47. (New) The solid-state imaging apparatus of Claim 45, further comprising a through hole passing through the base substrate.

48. (New) The solid-state imaging apparatus of Claim 46, wherein the through hole electrically connects an electrode disposed on the main surface and an electrode disposed on a back surface opposite to the main surface.

49. (New) The solid-state imaging apparatus of Claim 47, wherein the through hole electrically connects an electrode disposed on the main surface and an electrode disposed on a back surface opposite to the main surface.

50. (New) The solid-state imaging apparatus of Claim 44, further comprising a plurality of through holes passing through the base substrate.

51. (New) The solid-state imaging apparatus of Claim 45, further comprising a plurality of through holes passing through the base substrate.

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- 52. (New) The solid-state imaging apparatus of Claim 50, wherein the plurality of through holes electrically connect electrode disposed on the main surface and electrodes disposed on a back surface opposite to the main surface, respectively.
- 53. (New) The solid-state imaging apparatus of Claim 51, wherein the plurality of through holes electrically connect electrodes disposed on the main surface and electrodes disposed on a back surface opposite to the main surface, respectively.
- 54. (New) The solid-state imaging apparatus of Claim 52, wherein the plurality of through holes are insulated from each other.
- 55. (New) The solid state imaging apparatus of Claim 53, wherein the plurality of through holes are insulated from each other.
- 56. (New) The solid-state imaging apparatus of Claim 46, further comprising an electrode disposed on a back surface opposite to the main surface and connected to the through hole.
- 57. (New) The solid-state imaging apparatus of Claim 47, further comprising an electrode disposed on a back surface opposite to the main surface and connected to the through hole.